

DAC028N200ZY3

Silicon Carbide Enhancement Mode MOSFET

G (4

SS (3

D(1)

Features

- High blocking voltage with low Rds(on)
- High frequency operation with low Capacitance
- Simple to drive with -5/+18V gate
- Robust body diode with low Qrr
- 100% Avalanche Tested

Benefits

- · Superior robustness and system reliability
- Higher system efficiency
- Easier paralleling without thermal runaway
- Capable of high temperature application
- · Faster and more efficient switching

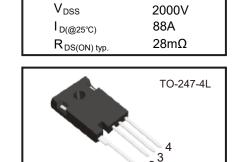
Applications

- EV motor drives
- EV/HEV charging station
- · Energy storage and Battery charging
- High voltage DC-DC converters
- Solar / Wind Inverters
- UPS and PFC

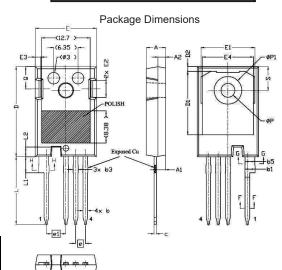
Absolute Maximum Ratings

(Tc = 25°C unless otherwise specified)

Parameter	Symbol	Ratings	Unit	
Drain-Source Voltage	V _{GS} =0V I⊳=100µA	V_{DS}	2000	V
Gate-Source Voltage (dynamic)	AC (f>1 Hz, duty cycle<1%, pulse width<200ns)	V _{GS}	-10/+25	V
Gate-Source Voltage (static)		$V_{\text{GS(op)}}$	-5/+18	V
Drain Current-Continuous	ss=18V@ T _C =25°C ss=18V@ T _C =100°C	Ι _D	88 60	А
Pulse Drain Current		I _{D,pulse}	260	А
Power Dissipation		P _D	535	W
Storage Temperature Range		T _{STG}	-55 to +175	°C
Operating Junction Temperatu	re Range	TJ	-55 to +175	°C
Soldering Temperature		TL	260	°C
Avalanche Capability, single puls	V _{DD} =100V se * V _{GS} =10V L=2mH	I _{AV}	50	A
Avalanche Capability, single pulse	e** V _{DD} =100V V _{GS} =10V L=2mH	E _{AV}	2500	mJ



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SYMBOL	DIMENSIONS			01000	DIMENSIONS			
SYMBOL	MIN.	NOM.	MAX.	SYMBOL	MIN. NOM. 15.75 15.94 13.10 14.02 3.68 4.40 1.00 1.45 12.38 13.26 2.54 BSC 17.31 17.57 3.97 4.19 2.35 2.50 3.51 3.61 7.19 REF 5.49 5.79	MAX		
A	4.83	5.02	5.21	E	15,75	15,94	16,13	
A1	2,29	2.41	2.54	E1	13,10	14.02	14.15	
A2	1.91	2.00	2.16	E2	3.68	4.40	5.10	
p,	1.07	1.20	1.28	E3	1.00	1.45	1.90	
b	1.07	1.20	1.33	E4	12,38	13,26	13,43	
b1	2.39	2.67	2.94	8	2.54 BSC			
b2	2.39	2.67	2.84	e1	5.08 BSC			
b3	1.07	1.30	1.60	L	17.31	17.57	17.82	
b4	1.07	1.30	1.50	L1	3,97	4,19	4,37	
b5	2,39	2.53	2.69	L2	2.35	2.50	2.65	
b6	2.39	2.53	2.64	ØP	3.51	3.61	3.65	
C	0.55	0.60	0.68	ØP1	1.000	7.19 REF	1	
c1	0,55	0,60	0,65	Q	5,49	5,79	6,00	
D	23,30	23.45	23.60	S	6.04	8.17	6.30	
D1	16.25	16.55	17.65					
D2	0.95	1.19	1.25					

* 100% tested in 60% rating ** 100% tested in 36% rating



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Electrical Characteristics @ Tc =2	5°C (unle	ess otherwise specified)	
Parameter	Symbol	Conditions	Min.

Parameter	Symbol	Conditions		Min.	Тур.	Max.	Unit
OFF Characteristics	-	-					
Drain-Source Breakdown Voltage	BVDSS	V _{GS} =0V , I _D =0.1mA		2000	-	-	V
Zero Gate Voltage Drain Current	Drain Current IDSS VDS = 2000V VGS = 0V VGS = 0V		T」=25℃	-	0.5	100	μA
		V _{GS} =0V	T」=175℃	-	5	-	μπ
Gate-Source Leakage Current	lgss	$V_{GS} = 18V , V_{DS} = 0V$		-	5	100	nA
		V_{GS} =-5V , V_{DS} =0V		-100	-5	-	
ON Characteristics							
Gate Threshold Voltage ***	V _{GS(th)}	V _{DS} = V _{GS} , I _D =15mA	T」=25℃	2.4	3.1	4.2	V
	V CO(iii)		T」=175℃	-	2.3	-	
Drain-Source On-State Resistance	RDS(on)	V _{GS} =18V,I _D =40A	T」=25℃	-	28	38	mΩ
			T」=175℃	-	70	-	
Transconductance	g fs	V _{DS} = 20V,I _D = 40A	T」=25℃	-	36	-	s
	3.0	VDS-20V , ID-40A	T」=175℃	-	33	-	
Internal Gate Resistance	RG(int.)	f =1MHz,ID =0A		-	1.1	-	Ω
Dynamic Characteristics							
Input Capacitance	Ciss	V _{DS} =1200V		-	4400	-	
Output Capacitance	Coss	Vgs =0V			100	-	pF
Reverse Transfer Capacitance	Crss	f =100kHz Vac =25mV		-	10	-	
Coss Stored Energy	Eoss			-	100	-	μJ
Turn-On Switching Energy	Eon	V _{DS} =1200V , V _{GS} =-5/+18V I _D =40A , R _{G(ext)} =2.0Ω L=200μH		-	900	-	μJ
Turn-Off Switching Energy	Eoff			-	160	-	
Switching Characteristics				<u> </u>			
Turn-On Delay Time	td(on)			-	20	-	
Rise Time	tr	V _{DS} =1200V,V _{GS} =-4/+18V I _D =40A,R _{G(ext)} =2.0Ω L=200μH		-	22	-	ns
Turn-Off Delay Time	td(off)			-	45	-	
Fall Time	tr			-	15	-	
Total Gate Charge	Qg	V _{DS} = 1200V		-	230	-	
Gate to Source Charge	Qgs	V _{GS} = -1200V V _{GS} = -5/+18V I _D = 40A		-	70	-	nC
Gate to Drain Charge	Qgd			-	86	-	
Body Diode Characteristics							
Inverse Diode Forward Voltage			T」=25℃	-	4.4	-	V
Inverse Diode Forward Voltage	Vsd	V_{GS} =-5V , I _{SD} =40A	T」=175℃	-	3.9	-	V
Continuous Diode Forward Current	ls	V _{GS} =-5V,T _J =25°C	I	-	90	-	Α
Reverse Recovery Time	Trr	I _{SD} =40A , V _{GS} =-5V V _R =1200V , T _J =25°C dif/dt=2647/μs		-	26	-	ns
Reverse Recovery Charge	Qrr			-	520	-	nC
Peak Reverse Recovery Current	Irrm			-	40	-	Α
Thermal Resistance							
Thermal Resistance, Junction-to-Case	Rθյc			-	0.25	0.22	°C/W
** Turne off with 0)/to 5)/ wate bias is bighty	1	I		I	1	1	I

*** Turn-off with -3V to -5V gate bias is highly recommended



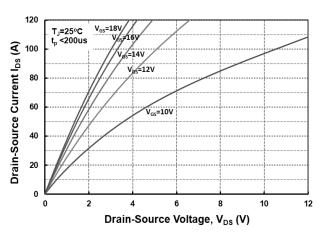


Fig 1. Output Characteristics, T_J = 25°C

Fig 3. Output Characteristics vs temp, Vgs=18V

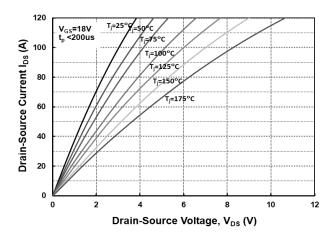
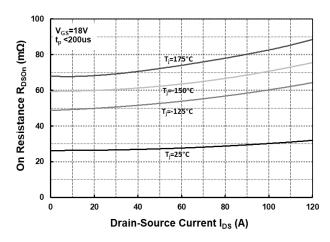


Fig 5. On-Resistance vs. Drain Current for Various Temperatures



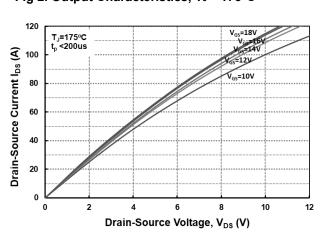


Fig 2. Output Characteristics, TJ = 175°C

Fig 4. Normalized On-Resistance vs. Temperature

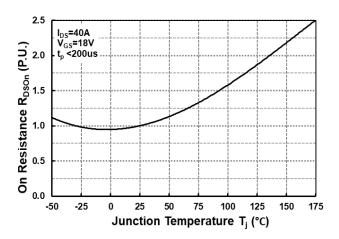
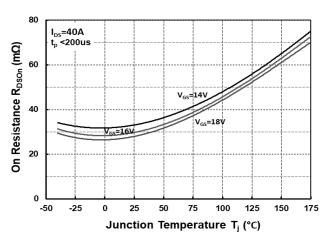


Fig 6. On-Resistance vs. Temperature for Various Gate Voltage





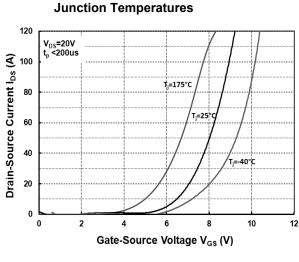
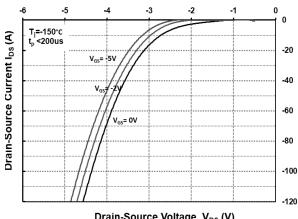


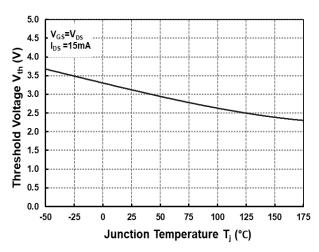
Fig 7. Transfer Characteristic for Various

Fig 9. Body Diode Characterisics @ 150°C



Drain-Source Voltage, V_{DS} (V)





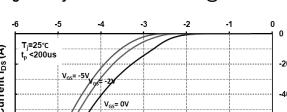


Fig 8. Body Diode Characteristics @ 25°C

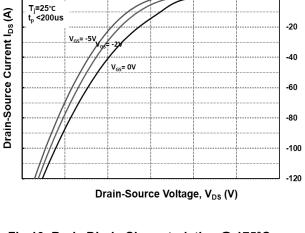
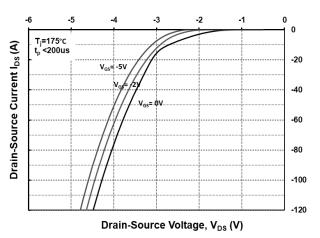
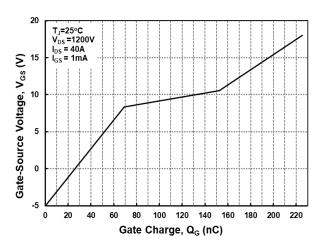


Fig 10. Body Diode Characteristics @ 175°C









DAC028N200ZY3

Typical Performance

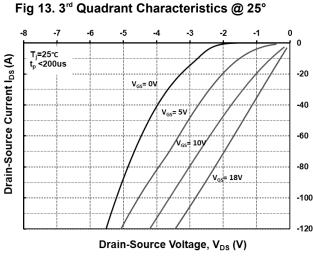
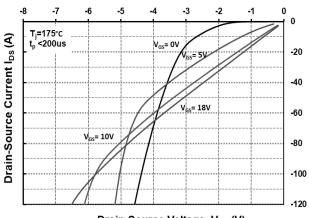
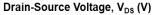
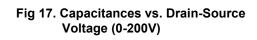
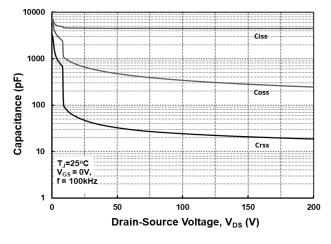


Fig 15. 3rd Quadrant Characteristics @ 175°C









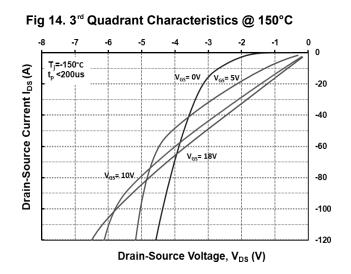


Fig 16. Output Capacitor Stored Energy

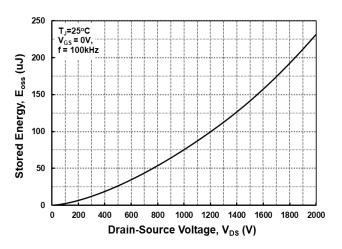
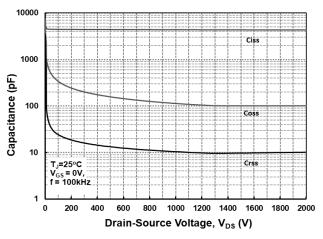
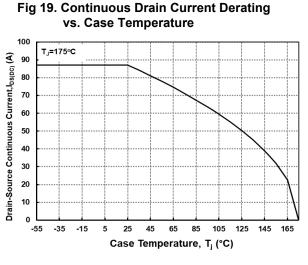
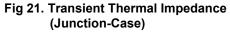


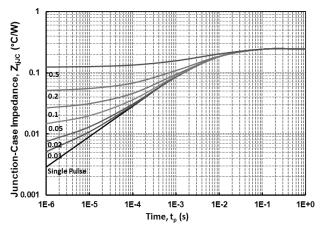
Fig 18. Capacitances vs. Drain-Source Voltage (0-2000V)

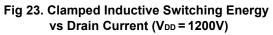












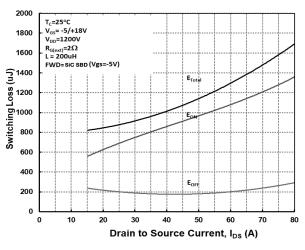


Fig 20. Maximum Power Dissipation Derating vs. Case Temperature

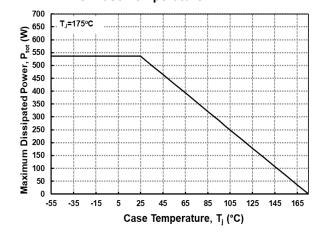


Fig 22. Safe Operating Area

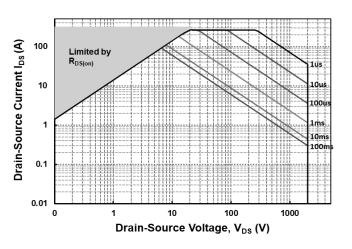
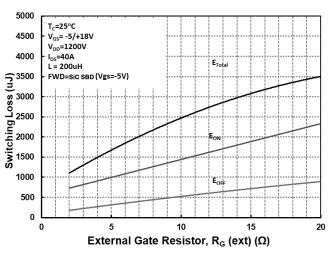


Fig 24. Clamped Inductive Switching Energy vs External Gate Resistor R_{G(ext)}





Drain to Source Current, I_{DS} (A)

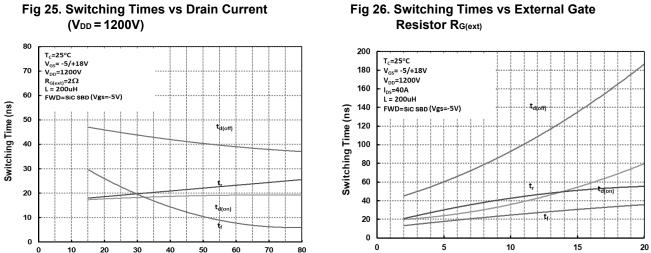


Fig 26. Switching Times vs External Gate

External Gate Resistor, R_G (ext) (Ω)



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